



# SLW28N50C

## 500V N-Channel MOSFET

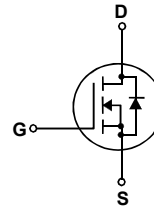
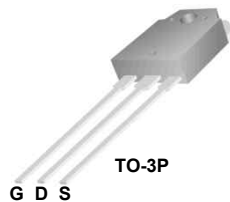
SLW28N50C

### General Description

This Power MOSFET is produced using Maple semi's advanced planar stripe DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction based on half bridge topology.

### Features

- 28A, 500V,  $R_{DS(on)typ.} = 0.17\Omega @ V_{GS} = 10V$
- Low gate charge ( typical 102nC)
- High ruggedness
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



### Absolute Maximum Ratings

$T_C = 25^\circ\text{C}$  unless otherwise noted

| Symbol         | Parameter                                                                     | SLW28N50C   | Units               |
|----------------|-------------------------------------------------------------------------------|-------------|---------------------|
| $V_{DSS}$      | Drain-Source Voltage                                                          | 500         | V                   |
| $I_D$          | Drain Current - Continuous ( $T_C = 25^\circ\text{C}$ )                       | 28          | A                   |
|                | - Continuous ( $T_C = 100^\circ\text{C}$ )                                    | 16.8        | A                   |
| $I_{DM}$       | Drain Current - Pulsed (Note 1)                                               | 112         | A                   |
| $V_{GSS}$      | Gate-Source Voltage                                                           | $\pm 30$    | V                   |
| EAS            | Single Pulsed Avalanche Energy (Note 2)                                       | 618         | mJ                  |
| $I_{AR}$       | Avalanche Current (Note 1)                                                    | 28          | A                   |
| $E_{AR}$       | Repetitive Avalanche Energy (Note 1)                                          | 43          | mJ                  |
| dv/dt          | Peak Diode Recovery dv/dt (Note 3)                                            | 4.5         | V/ns                |
| $P_D$          | Power Dissipation ( $T_C = 25^\circ\text{C}$ )                                | 479         | W                   |
|                | - Derate above $25^\circ\text{C}$                                             | 3.83        | W/ $^\circ\text{C}$ |
| $T_J, T_{STG}$ | Operating and Storage Temperature Range                                       | -55 to +150 | $^\circ\text{C}$    |
| $T_L$          | Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds | 300         | $^\circ\text{C}$    |

\* Drain current limited by maximum junction temperature.

### Thermal Characteristics

| Symbol          | Parameter                               | SLW28N50C | Units              |
|-----------------|-----------------------------------------|-----------|--------------------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case    | 0.26      | $^\circ\text{C/W}$ |
| $R_{\theta JS}$ | Thermal Resistance, Case-to-Sink Typ.   | 0.5       | $^\circ\text{C/W}$ |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | 62.5      | $^\circ\text{C/W}$ |

**Electrical Characteristics** $T_C = 25^\circ\text{C}$  unless otherwise noted

| Symbol                                                 | Parameter                                             | Test Conditions                                                                    | Min | Typ  | Max  | Units |
|--------------------------------------------------------|-------------------------------------------------------|------------------------------------------------------------------------------------|-----|------|------|-------|
| Off Characteristics                                    |                                                       |                                                                                    |     |      |      |       |
| BV <sub>DSS</sub>                                      | Drain-Source Breakdown Voltage                        | V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 uA                                     | 500 | --   | --   | V     |
| ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>                   | Breakdown Voltage Temperature Coefficient             | I <sub>D</sub> = 250 uA, Referenced to 25°C                                        | --  | 0.6  | --   | V/°C  |
| I <sub>DSS</sub>                                       | Zero Gate Voltage Drain Current                       | V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V                                     | --  | --   | 1    | uA    |
|                                                        |                                                       | V <sub>DS</sub> = 400 V, T <sub>C</sub> = 125°C                                    | --  | --   | 10   | uA    |
| I <sub>GSSF</sub>                                      | Gate-Body Leakage Current, Forward                    | V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V                                      | --  | --   | 100  | nA    |
| I <sub>GSSR</sub>                                      | Gate-Body Leakage Current, Reverse                    | V <sub>GS</sub> = -30 V, V <sub>DS</sub> = 0 V                                     | --  | --   | -100 | nA    |
| On Characteristics                                     |                                                       |                                                                                    |     |      |      |       |
| V <sub>GS(th)</sub>                                    | Gate Threshold Voltage                                | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 uA                        | 2.0 | --   | 4.0  | V     |
| R <sub>DS(on)</sub>                                    | Static Drain-Source On-Resistance                     | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 14 A                                      | --  | 0.17 | 0.22 | Ω     |
| g <sub>FS</sub>                                        | Forward Transconductance                              | V <sub>DS</sub> = 40 V, I <sub>D</sub> = 14 A (Note 4)                             | --  | 26   | --   | S     |
| Dynamic Characteristics                                |                                                       |                                                                                    |     |      |      |       |
| C <sub>iss</sub>                                       | Input Capacitance                                     | V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz                         | --  | 4085 | --   | pF    |
| C <sub>oss</sub>                                       | Output Capacitance                                    |                                                                                    | --  | 474  | --   | pF    |
| C <sub>rss</sub>                                       | Reverse Transfer Capacitance                          |                                                                                    | --  | 60   | --   | pF    |
| Switching Characteristics                              |                                                       |                                                                                    |     |      |      |       |
| t <sub>d(on)</sub>                                     | Turn-On Delay Time                                    | V <sub>DD</sub> = 250 V, I <sub>D</sub> = 28 A, R <sub>G</sub> = 25 Ω (Note 4, 5)  | --  | 45   | --   | ns    |
| t <sub>r</sub>                                         | Turn-On Rise Time                                     |                                                                                    | --  | 87   | --   | ns    |
| t <sub>d(off)</sub>                                    | Turn-Off Delay Time                                   |                                                                                    | --  | 355  | --   | ns    |
| t <sub>f</sub>                                         | Turn-Off Fall Time                                    |                                                                                    | --  | 130  | --   | ns    |
| Q <sub>g</sub>                                         | Total Gate Charge                                     | V <sub>DS</sub> = 400 V, I <sub>D</sub> = 28 A, V <sub>GS</sub> = 10 V (Note 4, 5) | --  | 102  | --   | nC    |
| Q <sub>gs</sub>                                        | Gate-Source Charge                                    |                                                                                    | --  | 43   | --   | nC    |
| Q <sub>gd</sub>                                        | Gate-Drain Charge                                     |                                                                                    | --  | 20   | --   | nC    |
| Drain-Source Diode Characteristics and Maximum Ratings |                                                       |                                                                                    |     |      |      |       |
| I <sub>S</sub>                                         | Maximum Continuous Drain-Source Diode Forward Current |                                                                                    | --  | --   | 28   | A     |
| I <sub>SM</sub>                                        | Maximum Pulsed Drain-Source Diode Forward Current     |                                                                                    | --  | --   | 112  | A     |
| V <sub>SD</sub>                                        | Drain-Source Diode Forward Voltage                    | V <sub>GS</sub> = 0 V, I <sub>S</sub> = 28 A                                       | --  | --   | 1.4  | V     |
| t <sub>rr</sub>                                        | Reverse Recovery Time                                 | V <sub>GS</sub> = 0 V, I <sub>S</sub> = 28 A,                                      | --  | 656  | --   | ns    |
| Q <sub>rr</sub>                                        | Reverse Recovery Charge                               | di <sub>F</sub> / dt = 100 A/us (Note 4)                                           | --  | 11.5 | --   | uC    |

**Notes:**

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2.  $L = 12\text{mH}, I_{AS} = 4\text{ A}, V_{DD} = 50\text{ V}, R_G = 25\text{ }\Omega$ , Starting  $T_J = 25^\circ\text{C}$
3.  $I_{SD} \leq 28\text{ A}, di/dt \leq 100\text{ A}/\mu\text{s}, V_{DD} \leq BV_{DSS}$ , Starting  $T_J = 25^\circ\text{C}$
4. Pulse Test : Pulse width  $\leq 300\mu\text{s}$ , Duty cycle  $\leq 2\%$
5. Essentially independent of operating temperature

## Typical Characteristics

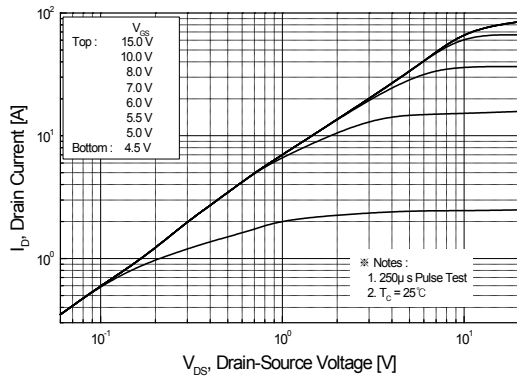


Figure 1. On-Region Characteristics

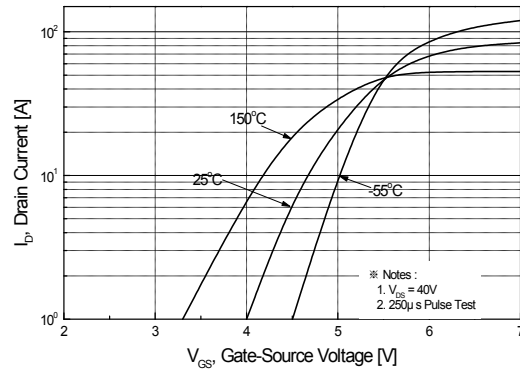


Figure 2. Transfer Characteristics

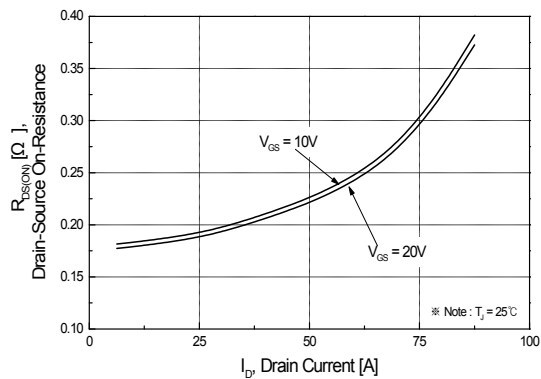


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

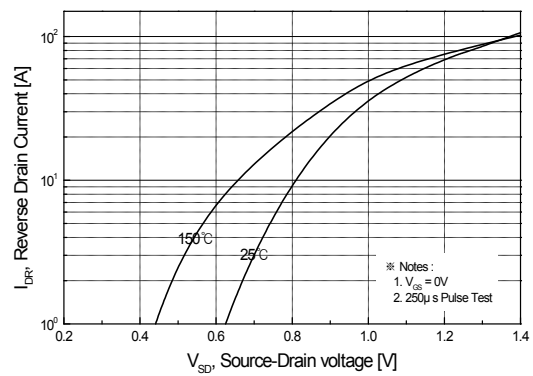


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

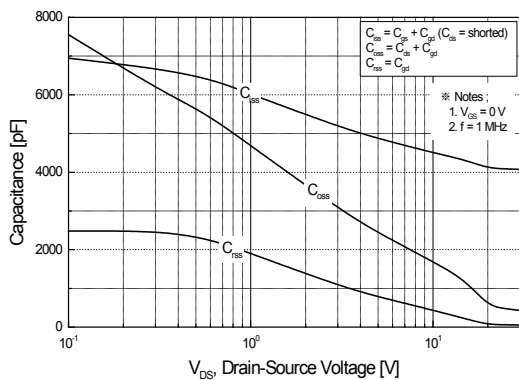


Figure 5. Capacitance Characteristics

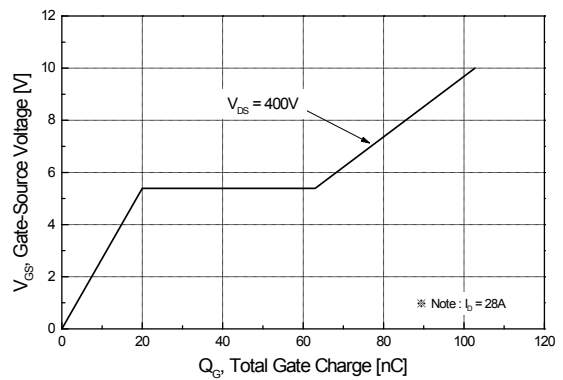
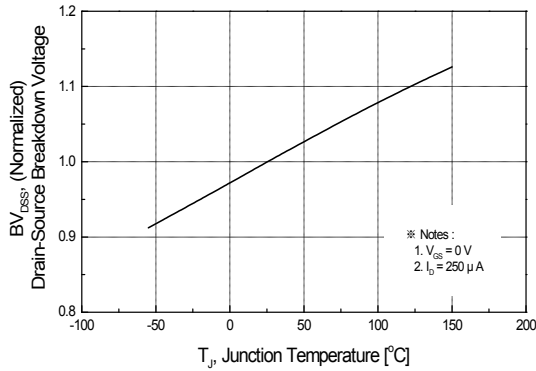
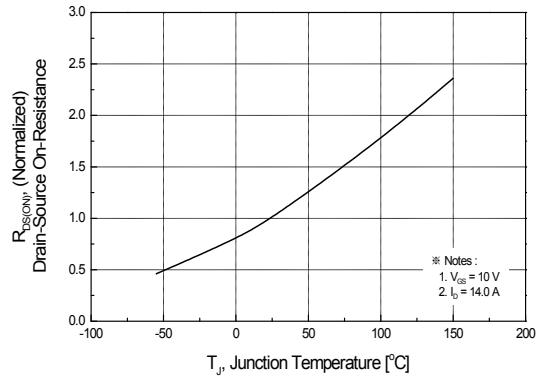


Figure 6. Gate Charge Characteristics

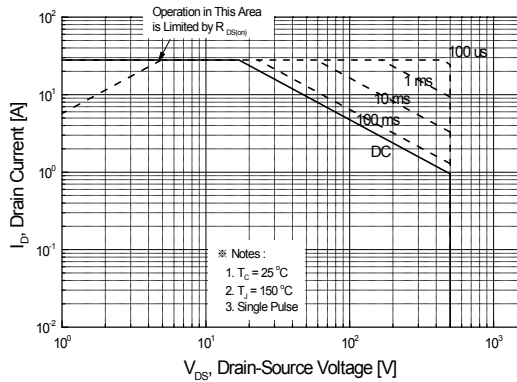
## Typical Characteristics (Continued)



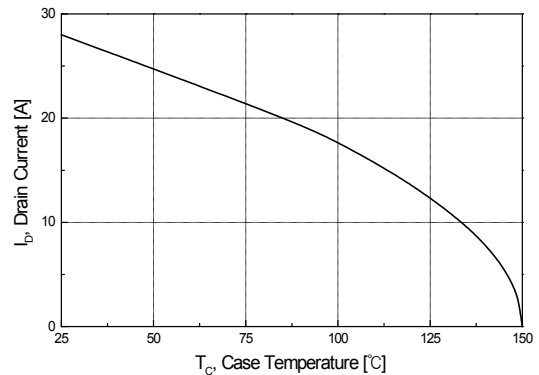
**Figure 7. Breakdown Voltage Variation vs Temperature**



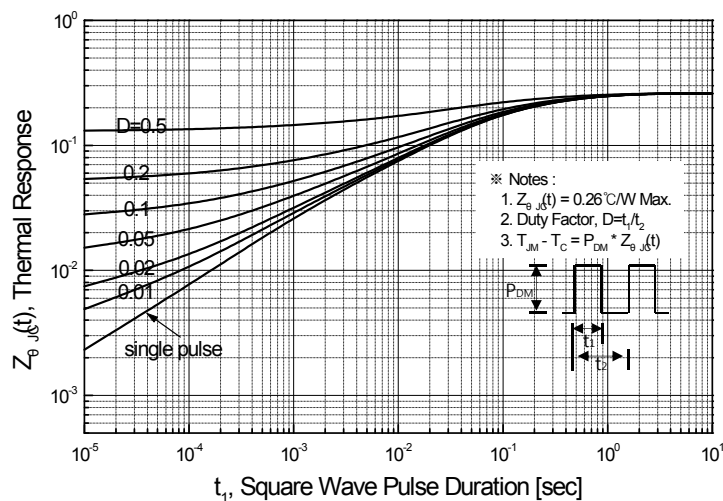
**Figure 8. On-Resistance Variation vs Temperature**



**Figure 9. Maximum Safe Operating Area**

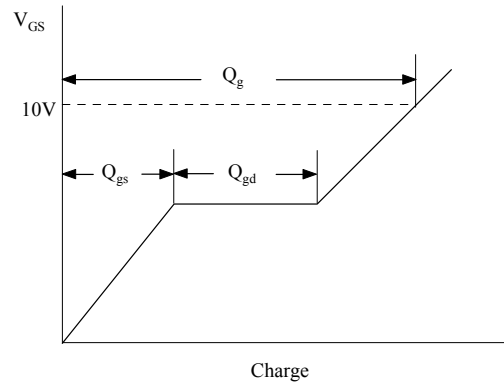
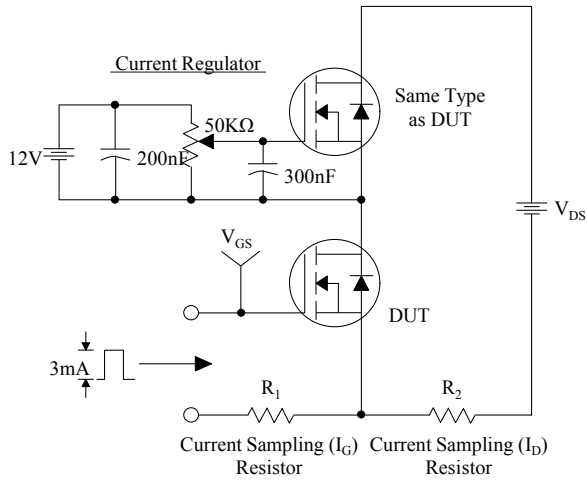


**Figure 10. Maximum Drain Current vs Case Temperature**

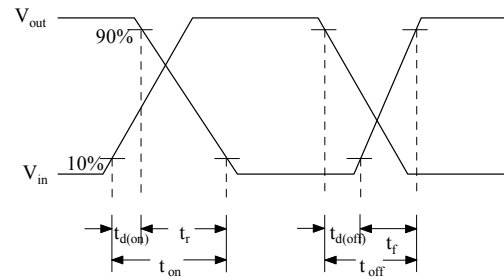
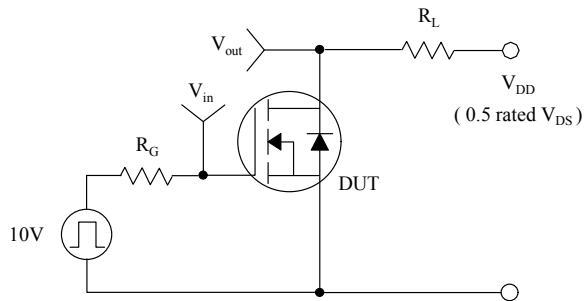


**Figure 11. Transient Thermal Response Curve**

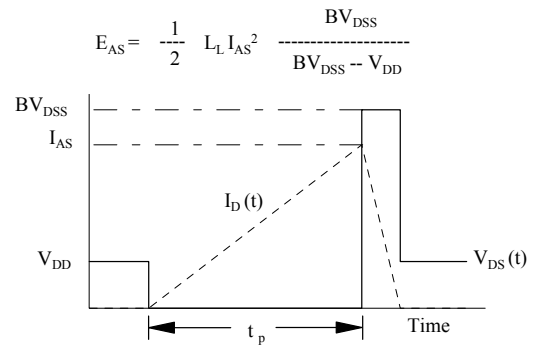
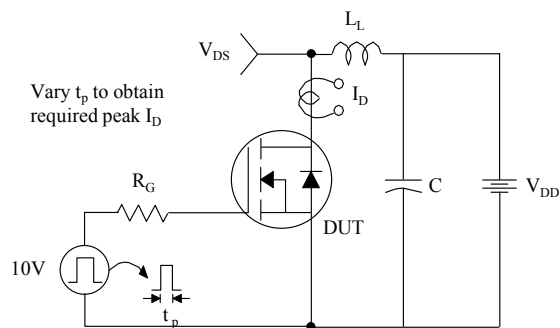
### Gate Charge Test Circuit & Waveform



### Resistive Switching Test Circuit & Waveforms



### Unclamped Inductive Switching Test Circuit & Waveforms



## Peak Diode Recovery dv/dt Test Circuit & Waveforms

